

Status of the B lifetime study with the lepton+D⁰ events

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We are interested in measuring the B⁺/B⁰ lifetime and its ratio using lepton + D⁰(D^{*-}) events.

This is basically a repetition of the Fumi's analysis in Run I (CDF4534).

The only difference is the trigger strategy (8GeV lepton in Run I, 4 GeV lepton + SVT track in Run II).

For the B⁺/B⁰ lifetime ratio, Run I analysis was not limited by systematics.

$$(B^+/B^0 = 1.110 + 0.056^{+0.033}_{-0.030})$$

So we have a chance to improve the uncertainty in Run II.

Obviously the critical issue is the understanding the SVT trigger bias ...

Possible systematics from SVT bias

We cut on the SVT d_0 as $120 \mu\text{m} < d_0 < 1000 \mu\text{m}$.

Basically the SVT bias curve for the lifetime can be obtained from the MC, but we need to know the SVT d_0 resolution properly.

(note: The systematics from the SVT d_0 resolution can be reduced by applying tighter d_0 cut offline.)

SVT tracking efficiency dependence for the SVT d_0 gives further bias to the lifetime.

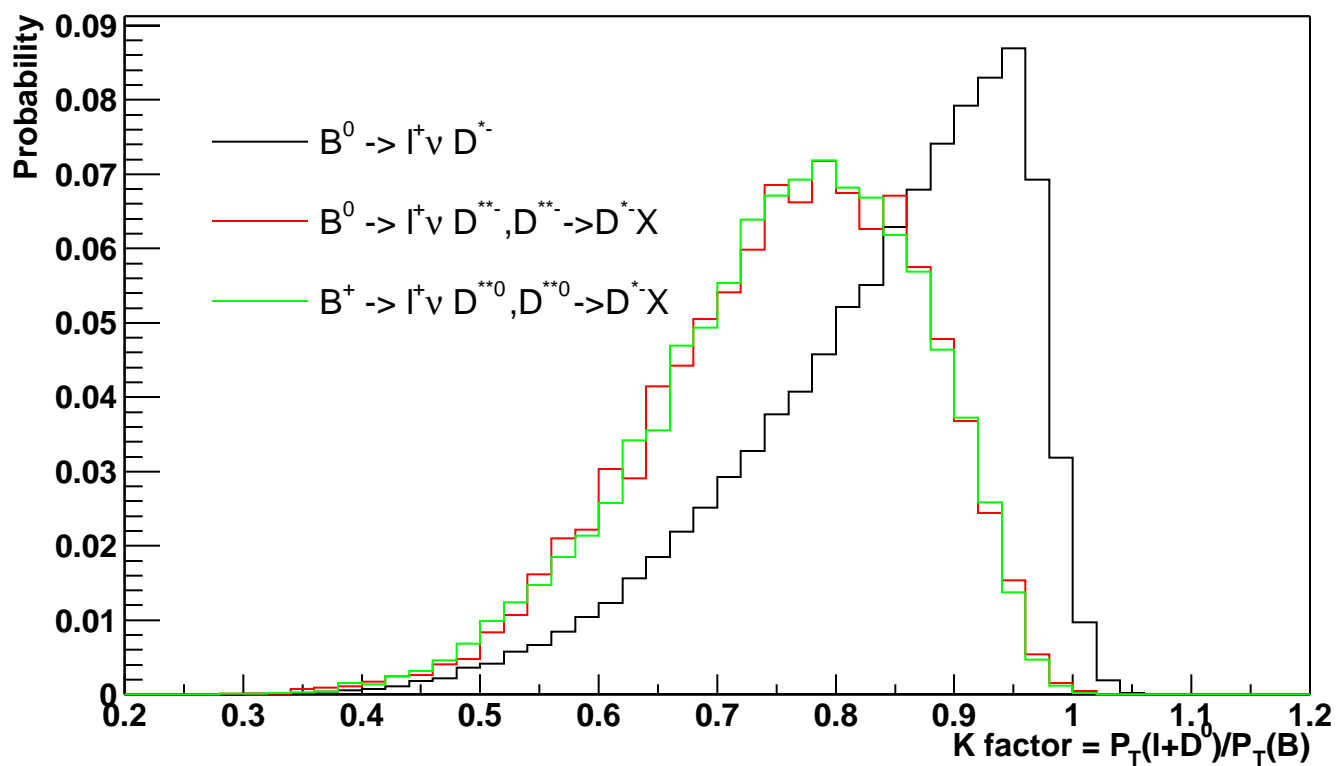
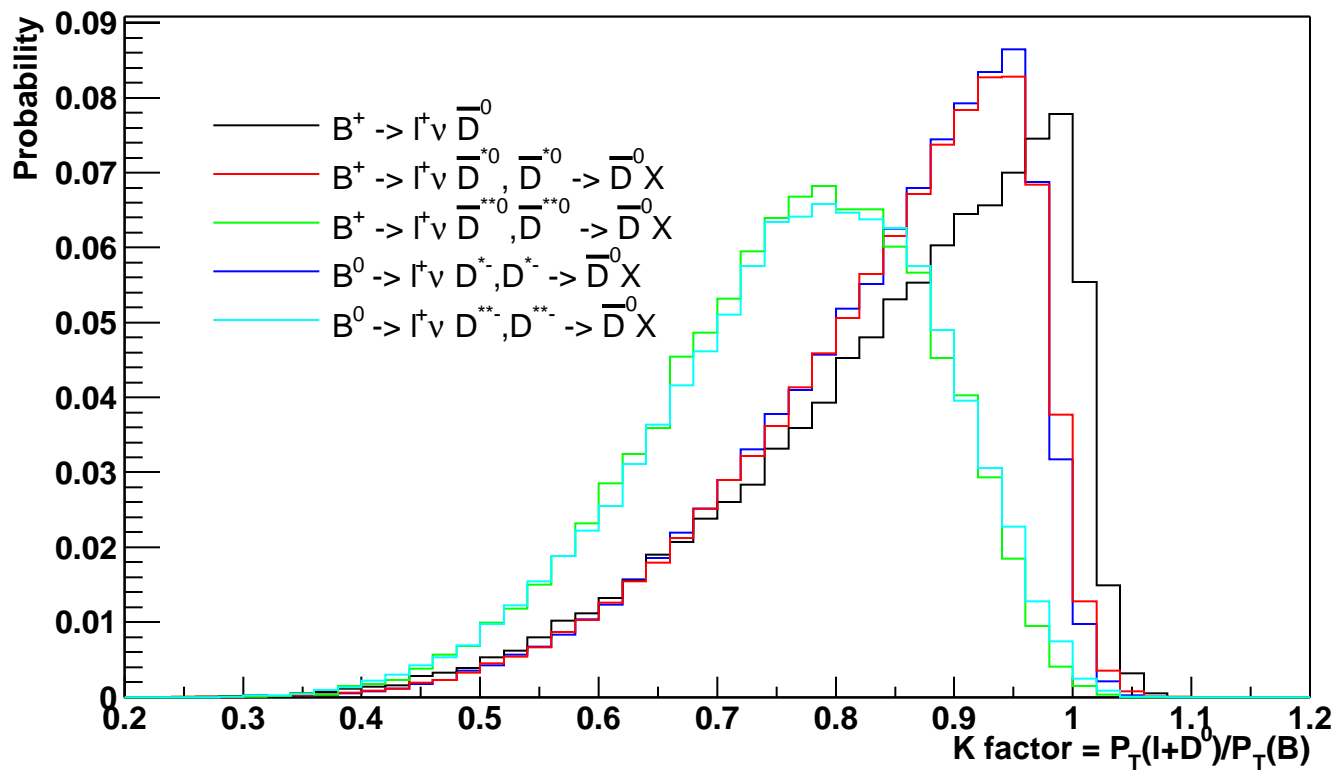
Also, SVT bias to the lifetime is different for the different decay modes.

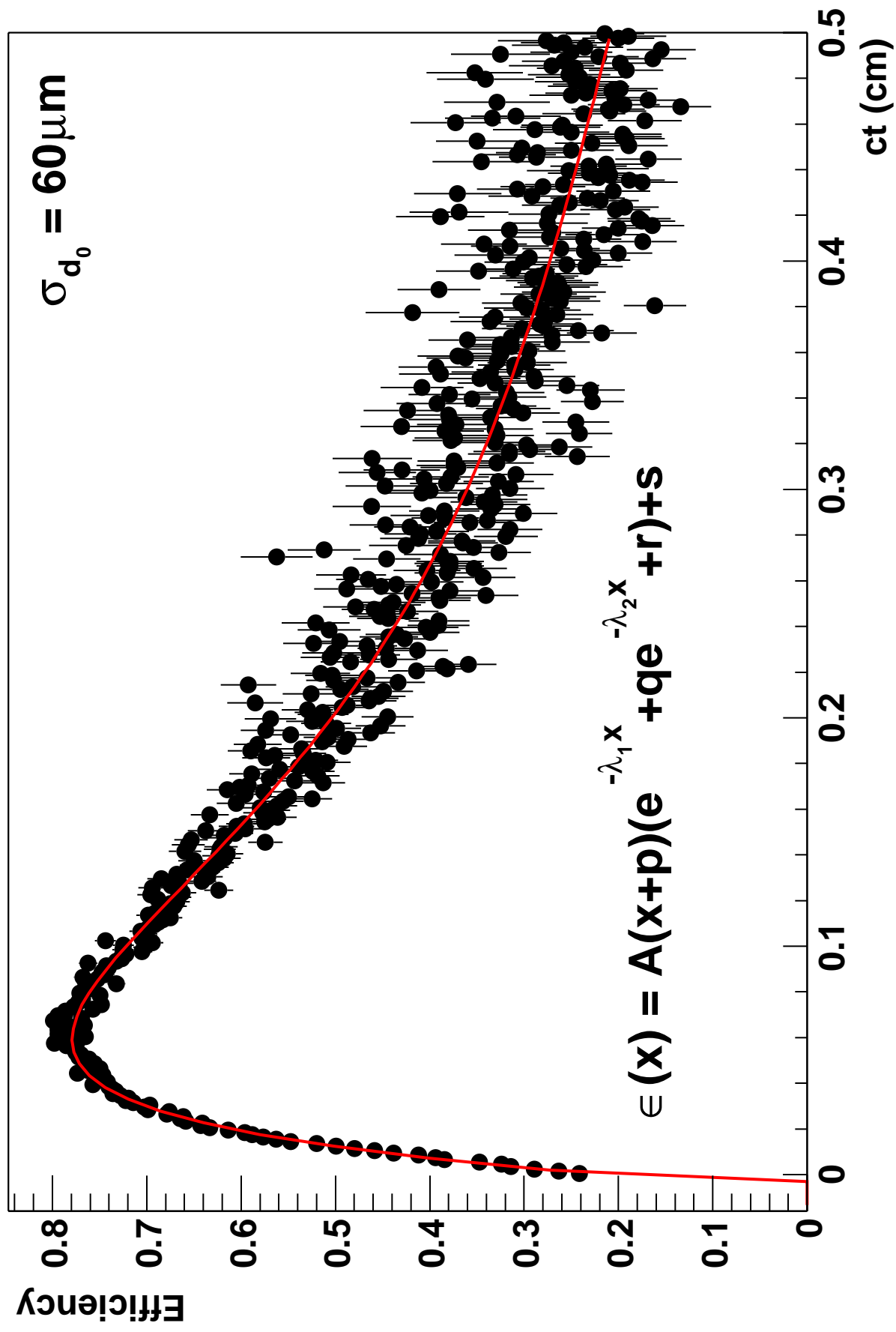
This won't be cancelled even in the B^+ / B^0 lifetime ratio.

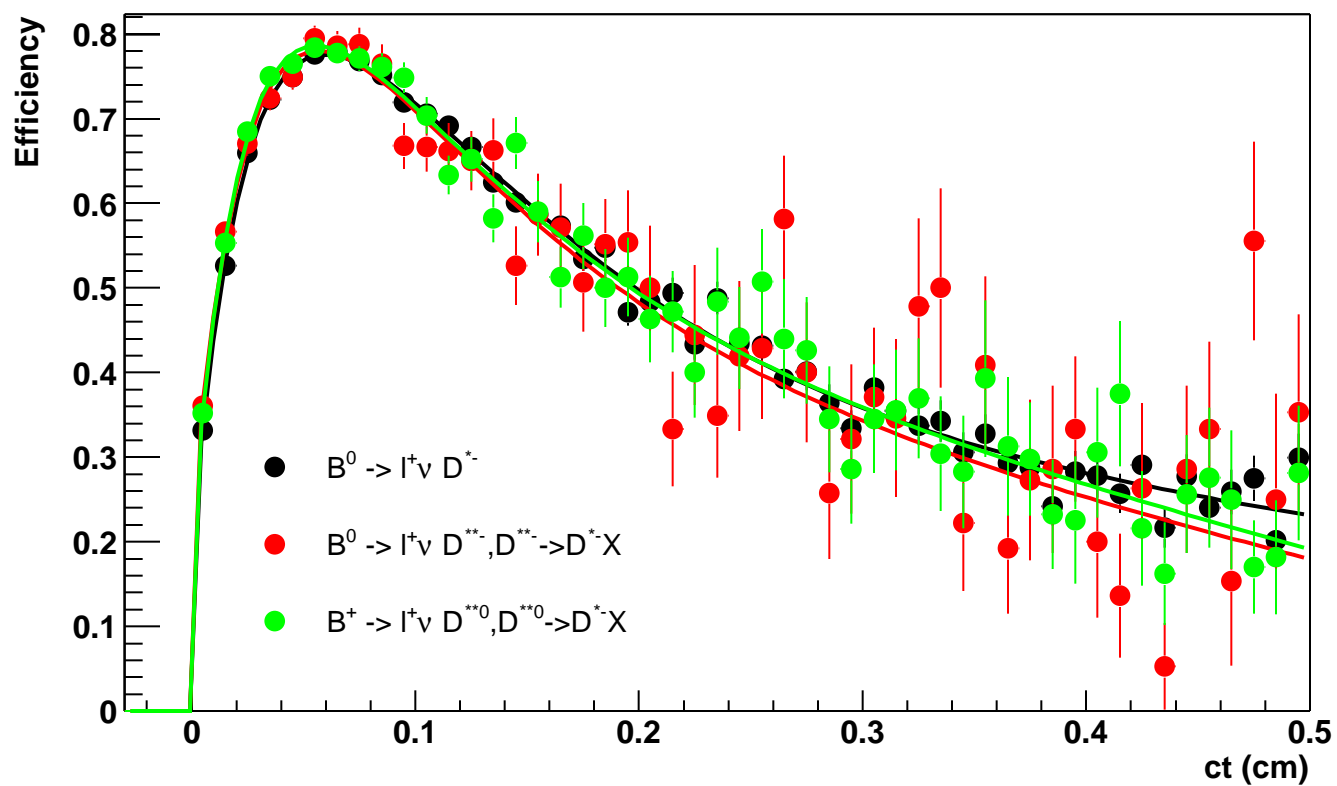
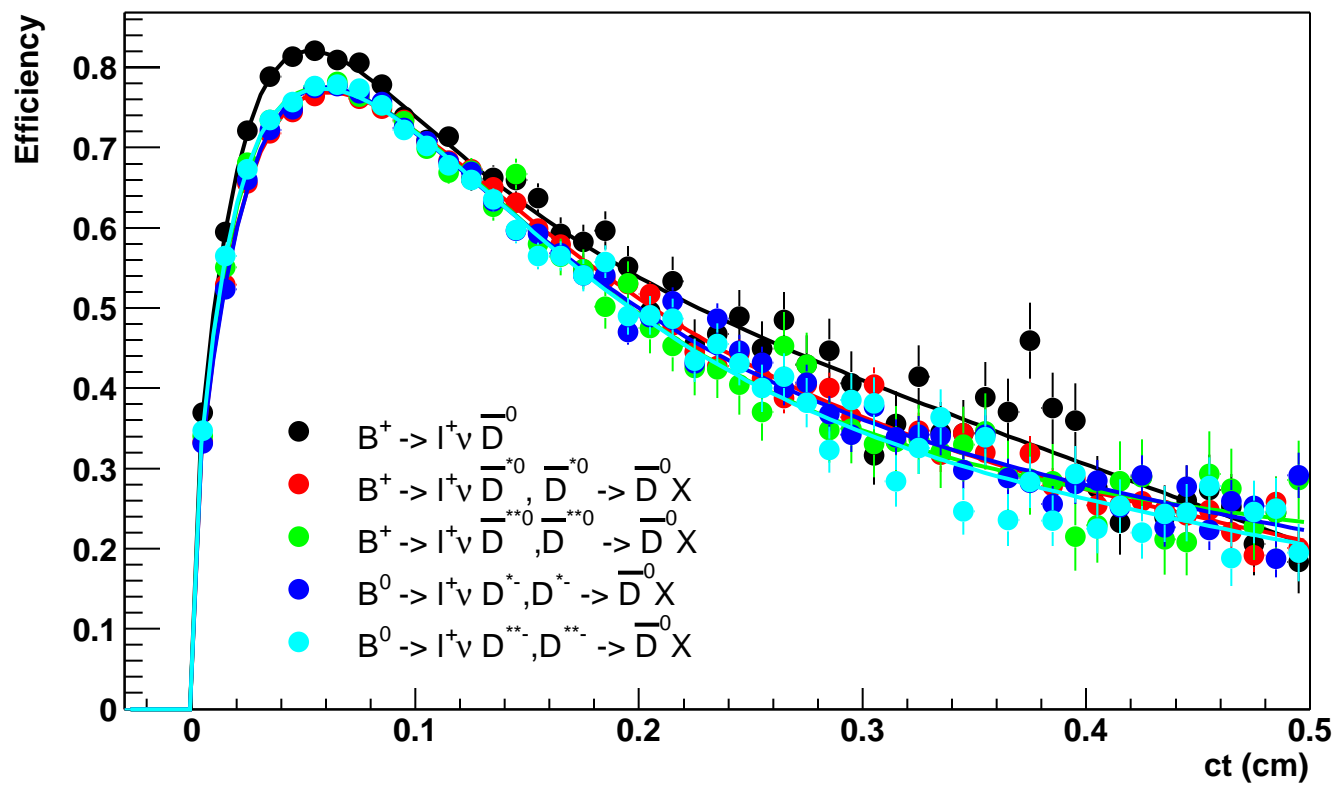
We are trying to understand these effect using a generator level MC (Bgenerator + QQ) and toy MC.

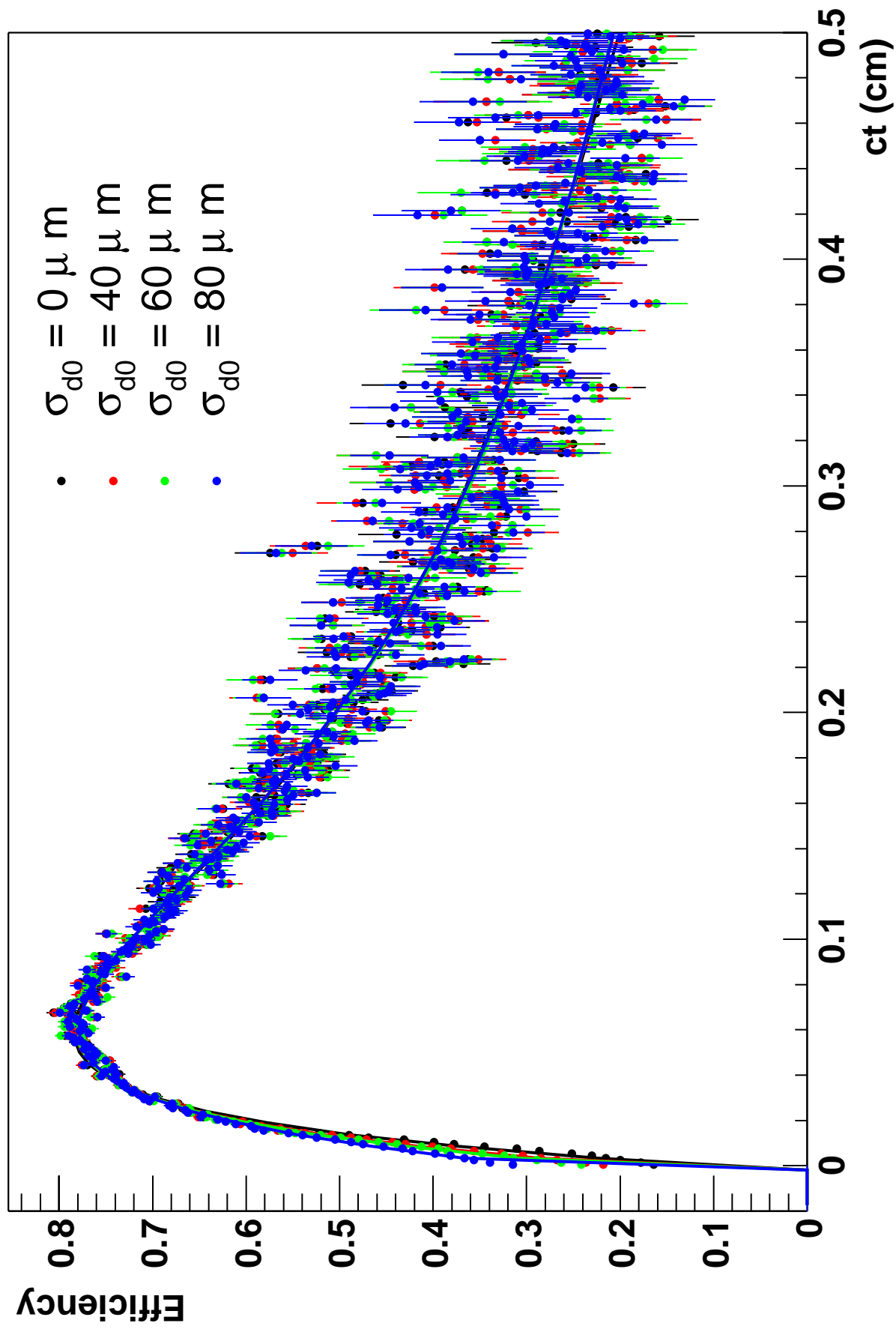
We estimate the K factor and SVT bias for the lifetime from generator level MC.

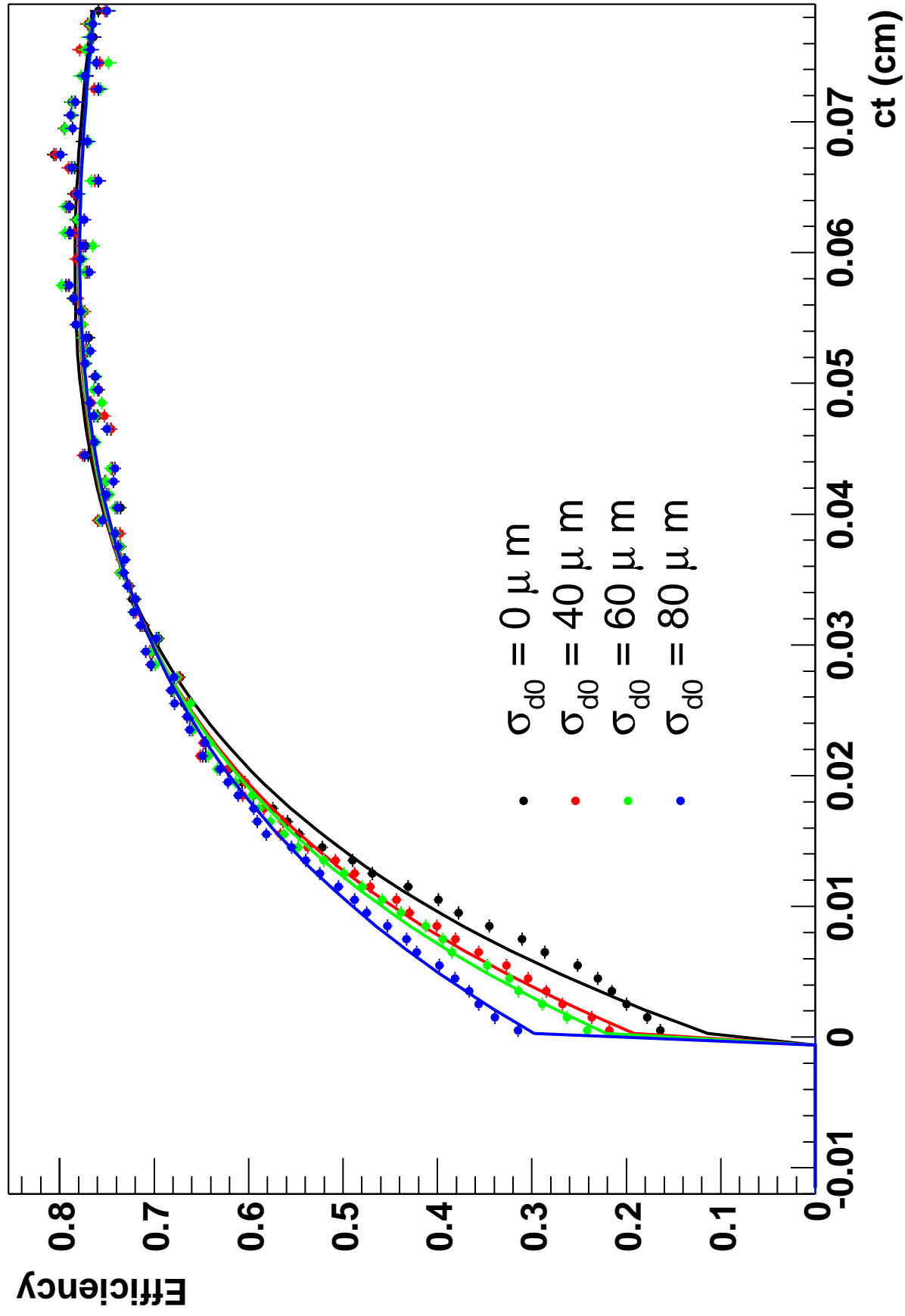
Then generate the toy MC events with it, and try to fit them and estimate possible systematics from the SVT bias.

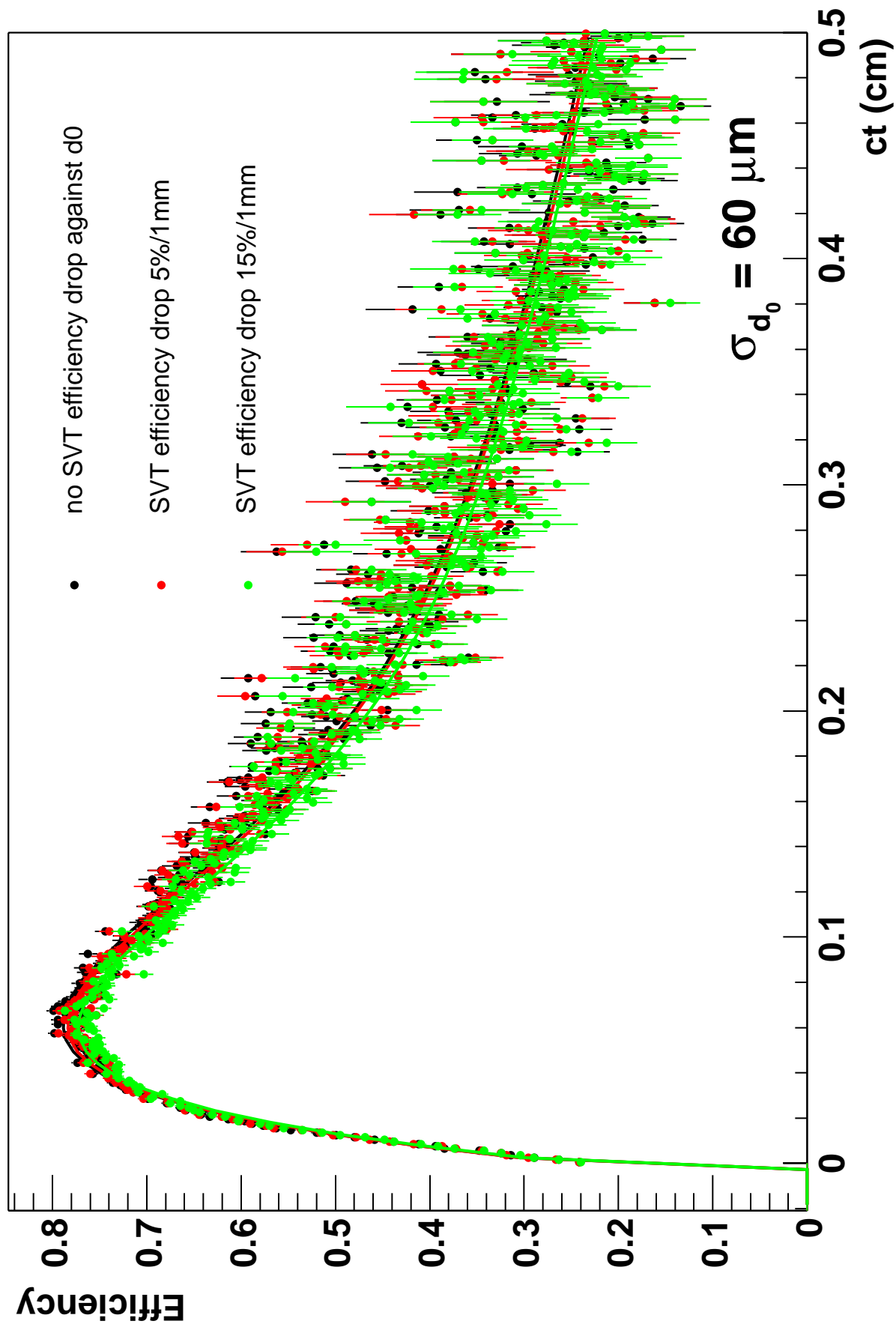


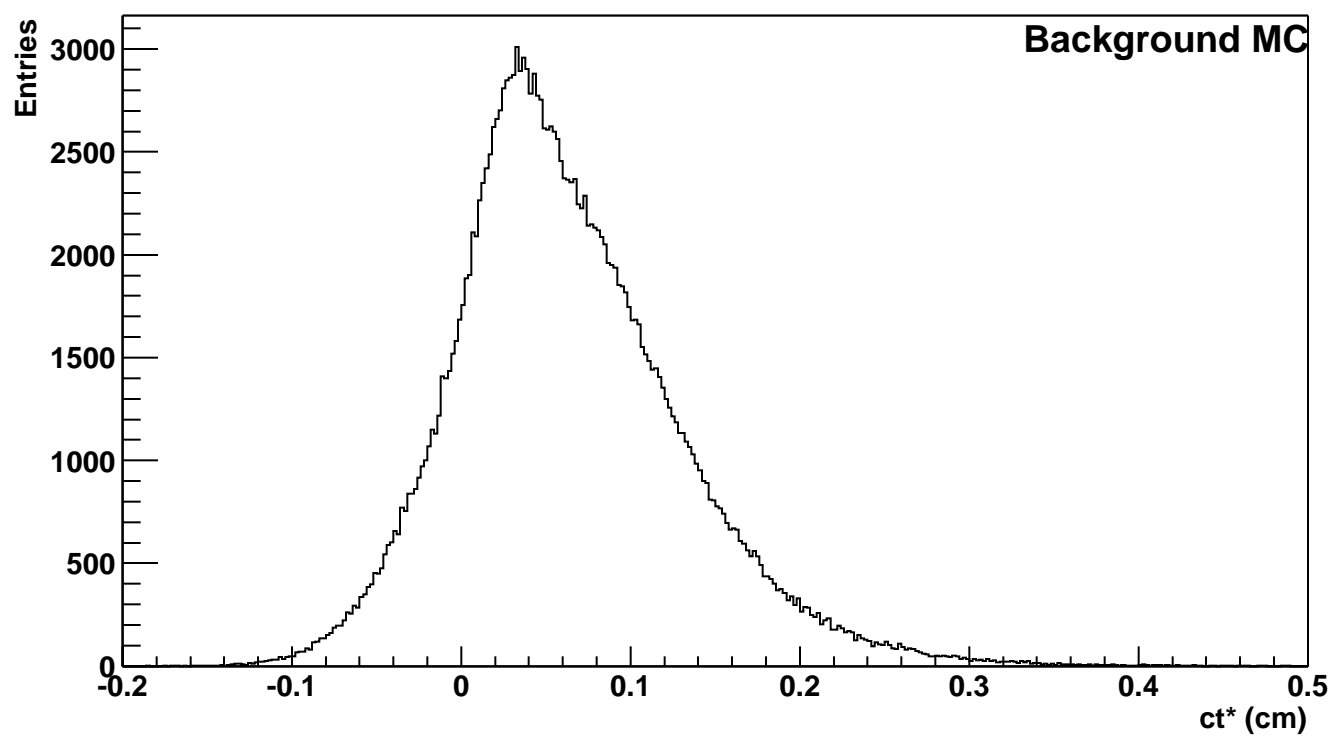
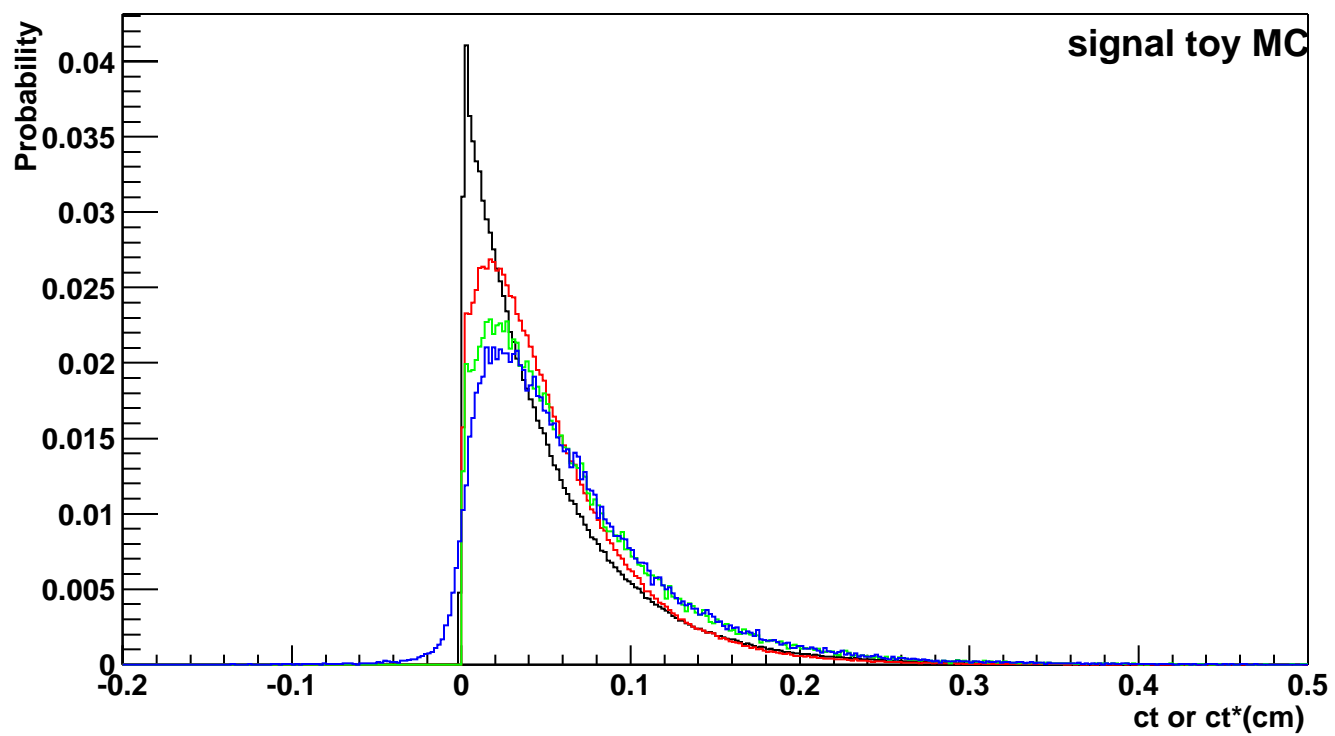


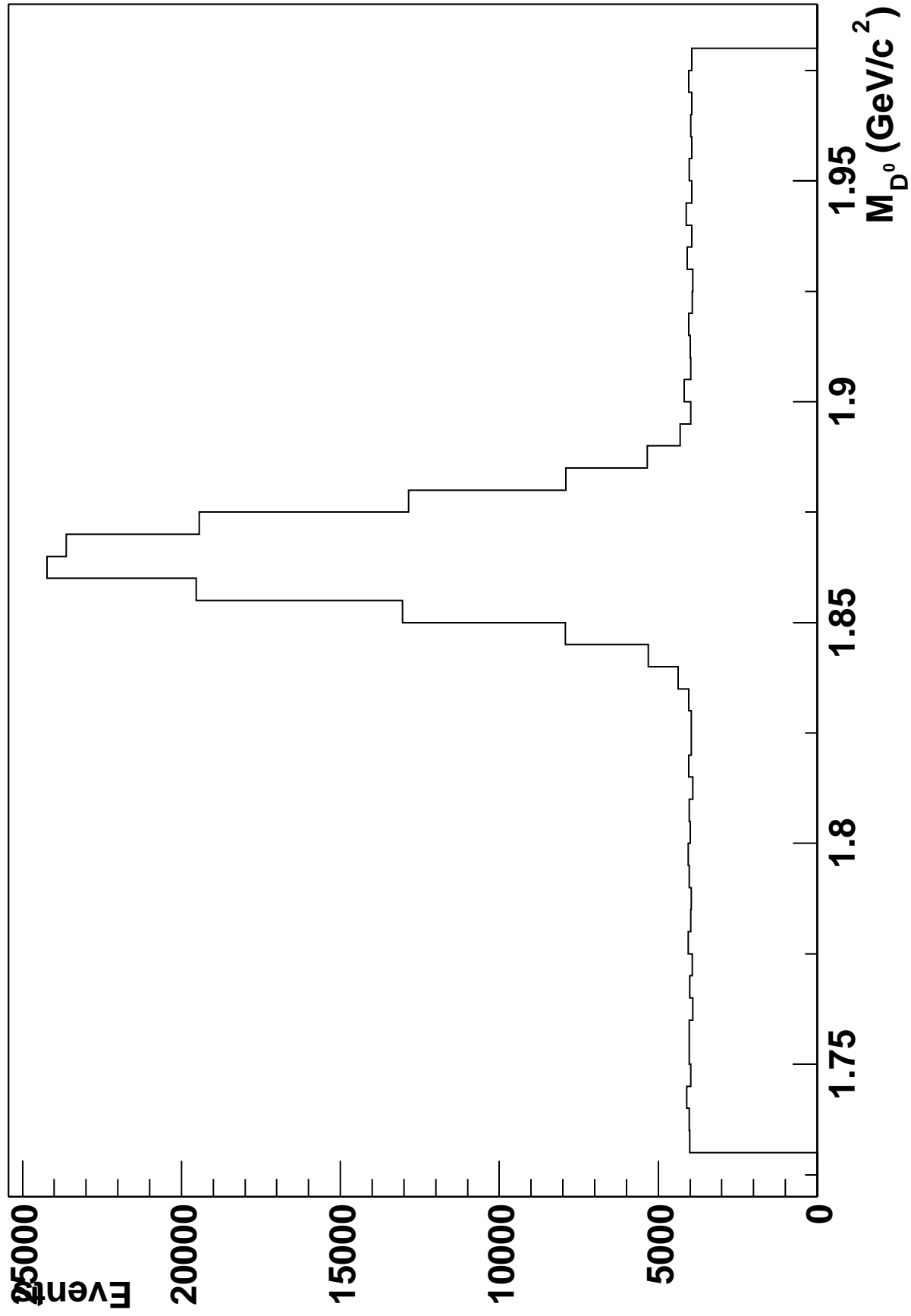


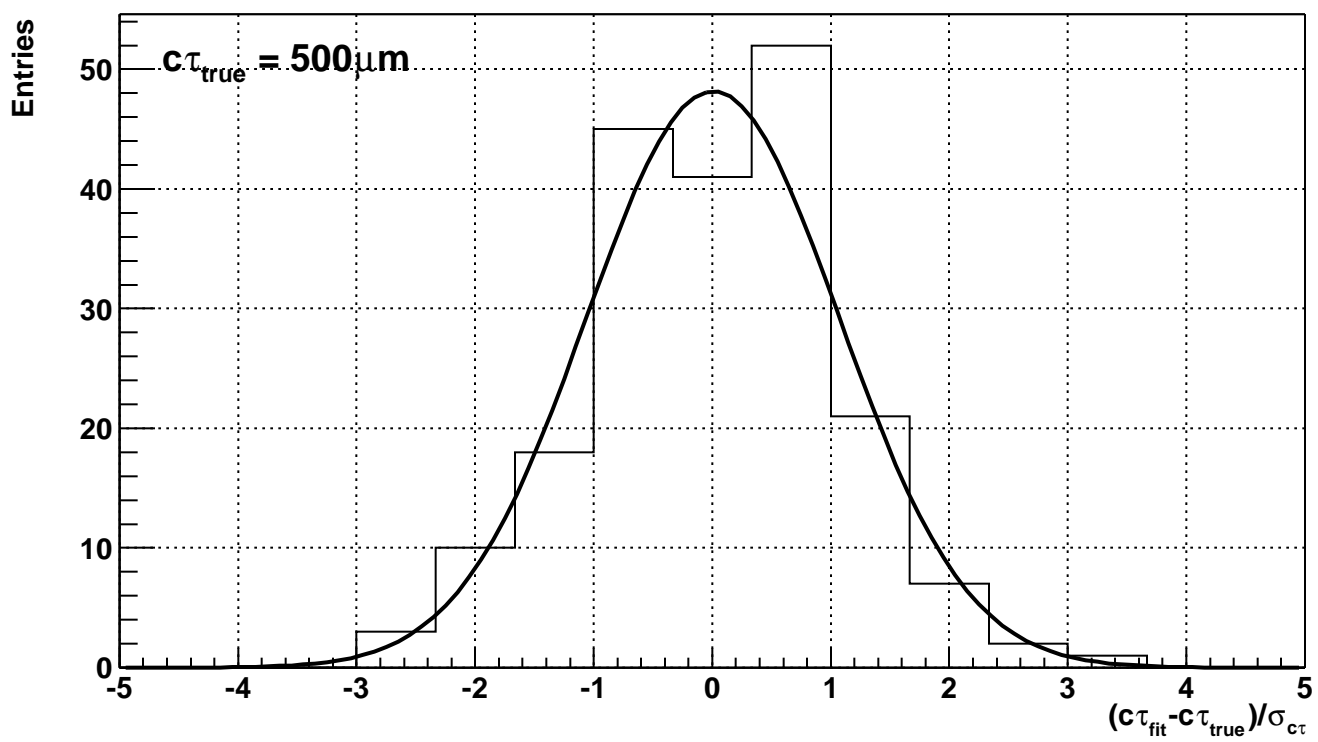
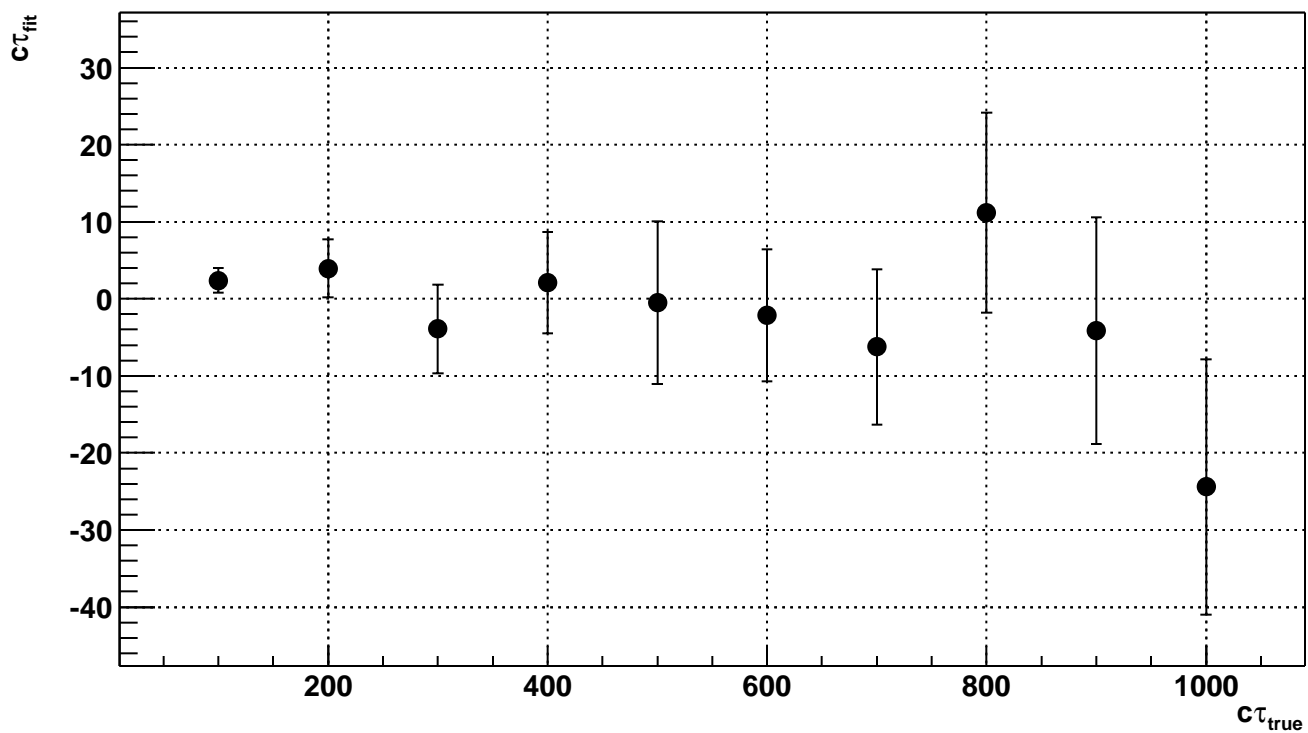












Assuming $\sigma_{d0} = 60 \mu\text{m}$ and no SVT efficiency drop against d_0 , do the fit to the toy MC events ($c\tau_{\text{true}} = 500 \mu\text{m}$, 100K events) generated with ...

- (a) ... $\sigma_{d0} = 60 \mu\text{m}$, no efficiency drop
- (b) ... $\sigma_{d0} = 40 \mu\text{m}$, no efficiency drop
- (c) ... $\sigma_{d0} = 80 \mu\text{m}$, no efficiency drop
- (d) ... $\sigma_{d0} = 60 \mu\text{m}$, efficiency drops
5% at $d_0 = 1\text{mm}$
- (e) ... $\sigma_{d0} = 60 \mu\text{m}$, efficiency drops
15% at $d_0 = 1\text{mm}$

Fit results :

- (a) $499.2 \pm 2.3 \mu\text{m}$
- (b) $508.0 \pm 2.3 \mu\text{m}$
- (c) $490.4 \pm 2.3 \mu\text{m}$
- (d) $503.2 \pm 2.3 \mu\text{m}$
- (e) $500.6 \pm 2.3 \mu\text{m}$

Summary

To reduce systmatics $< 15 \mu\text{m}$
from the SVT trigger bias,

- need to understand σ_{d0} of the SVT
- need to understand $\mathcal{E}_{\text{SVT}}(d0)$

Plans

Study with generator-level MC

Further systematics study from,

- SVT
- brems electron (could be change K factor)
- other possible source